

Form PTO 1449
(Modified)

ATTY DOCKET NO.

214607US2

SERIAL NO.

09/964,585

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toyoji IKEZAWA, et al.

FILING DATE

September 28, 2001

GROUP

2171

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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	AH						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	YES	NO
<i>Elik</i>	AO	2001-250022	09/14/2001	JAPAN (with English translation)			
	AP	2000-242724	09/08/2000	JAPAN (with English translation)			
	AQ	9-160979	06/20/97	JAPAN (with English translation)			
	AR	9-6838	01/10/97	JAPAN (with English translation)			
	AS						
	AT						
	AU						
	AV						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

 Additional References sheet(s) attached

Examiner

E.P. Lehoux

Date Considered

2/12/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

MAY 28 2003

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	YES	NO
Eck	AO	10-011498	01/16/98	JAPAN (with English Abstract)			X
Eck	AP	07-230442	08/29/95	JAPAN (with English Abstract)			X
Eck	AQ	2000-222486	08/11/2000	JAPAN (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AW	
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AY	
AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

SP Lehman

Date Considered

2/12/04

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